## Application/Control No. Applicant(s)/Patent Under Reexamination 10/629,835 **FURUMIYA ET AL.** Notice of References Cited Art Unit Examiner Page 1 of 1 2627 Kim-Kwok CHU **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,513,165 04-1996 Ide et al. 369/116 Α 369/59.12 US-4,873,680 10-1989 Chung et al. В С US-US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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